

Search Notes

Application No.

09/652,159

Examiner

Vanel Frenel

Applicant(s)

LIU ET AL.

Art Unit

3626

SEARCHED

Class	Subclass	Date	Examiner
705	5	10/3/2004	V.F

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
West 2.0 ; Other Databases:USPAT; EPO; JPO;DERWENT WORLD PATENTS INDEX; IBM TECHNICAL DISCLOSURE BULLETINS	10/3/2004	V.F